

1.8V Nanopower Comparator with Internal 1.245V Reference

FEATURES

- ◆ Second-source for MAX917
- ◆ Guaranteed to Operate Down to +1.8V
- ◆ Ultra-Low Supply Current: 750nA
- ◆ Internal 1.245V $\pm 1.5\%$ Reference
- ◆ Input Voltage Range Extends 200mV Outside-the-Rails
- ◆ No Phase Reversal for Overdriven Inputs
- ◆ Push-pull Output
- ◆ Crowbar-Current-Free Switching
- ◆ Internal Hysteresis for Clean Switching
- ◆ 5-pin SOT23 and 8-pin SOIC Packaging

APPLICATIONS

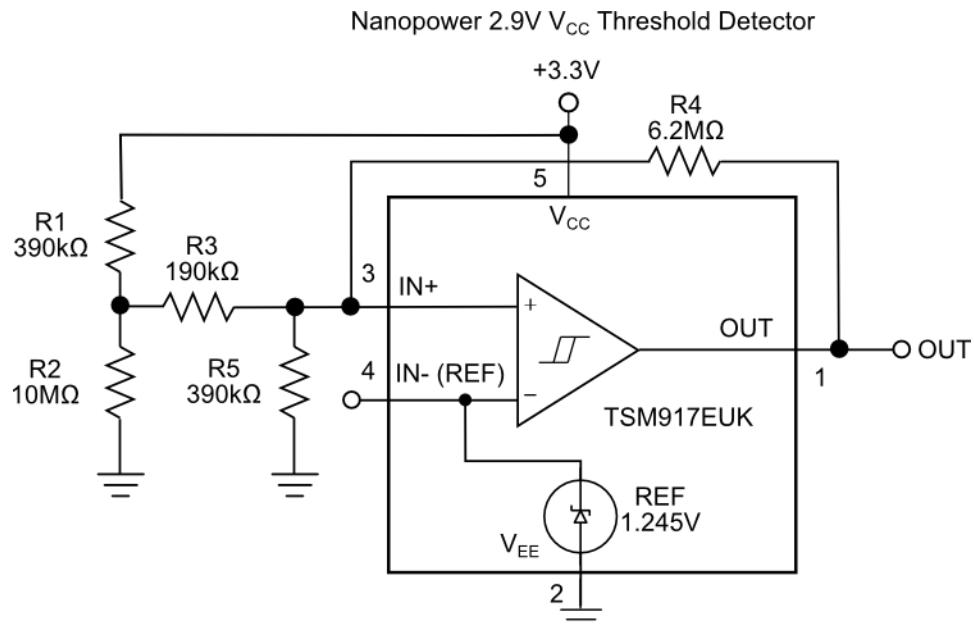
- 2-Cell Battery Monitoring/Management
- Medical Instruments
- Threshold Detectors/Discriminators
- Sensing at Ground or Supply Line
- Ultra-Low-Power Systems
- Mobile Communications
- Telemetry and Remote Systems

DESCRIPTION

The TSM917 nanopower analog comparator is electrically and form-factor identical to the MAX917 analog comparator. Ideally suited for all 2-cell battery-management/monitoring applications, this 5-pin SOT23 analog comparator guarantees +1.8V operation, draws very little supply current, and has a robust input stage that can tolerate input voltages beyond its power supply. The TSM917 draws 750nA of supply current and includes an on-board 1.245V $\pm 1.5\%$ reference.

The TSM917's push-pull output drivers were designed to drive 8mA loads from one supply rail to the other supply rail. The TSM917 is also available in an 8-pin SOIC package.

TYPICAL APPLICATION CIRCUIT



The Touchstone Semiconductor logo is a registered trademark of Touchstone Semiconductor, Incorporated.

ABSOLUTE MAXIMUM RATINGS

Supply Voltage (V _{CC} to V _{EE})	+6V
Voltage Inputs (IN+, IN-, REF) (V _{EE} - 0.3V) to (V _{CC} + 0.3V)	
Output Voltage TSM917	(V _{EE} - 0.3V) to (V _{CC} + 0.3V)
Current Into Input Pins	±20mA
Output Current	±50mA
Output Short-Circuit Duration	10s

Continuous Power Dissipation (T _A = +70°C)	
5-Pin SC70 (Derate 2.5mW/°C above +70°C)	200mW
8-Pin SOIC (Derate 5.88mW/°C above +70°C)	471mW
Operating Temperature Range	-40°C to +85°C
Junction Temperature	+150°C
Storage Temperature Range	-65°C to +150°C
Lead Temperature (soldering, 10s)	+300°

Electrical and thermal stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other condition beyond those indicated in the operational sections of the specifications is not implied. Exposure to any absolute maximum rating conditions for extended periods may affect device reliability and lifetime.

PACKAGE/ORDERING INFORMATION

TOP VIEW				TOP VIEW			
ORDER NUMBER	PART MARKING	CARRIER	QUANTITY	ORDER NUMBER	PART MARKING	CARRIER	QUANTITY
TSM917EUK+	TAAA	Tape & Reel	-----	TSM917ESA+	TS917E	Tube	97
TSM917EUK+T		Tape & Reel	3000	TSM917ESA+T		Tape & Reel	2500

Lead-free Program: Touchstone Semiconductor supplies only lead-free packaging.

Consult Touchstone Semiconductor for products specified with wider operating temperature ranges.

ELECTRICAL CHARACTERISTICS

$V_{CC} = +5V$, $V_{EE} = 0V$, $V_{IN+} = V_{REF}$, $T_A = -40^\circ C$ to $+85^\circ C$, unless otherwise noted. Typical values are at $T_A = +25^\circ C$. See Note 1.

PARAMETER	SYMBOL	CONDITIONS	MIN	Typ	MAX	UNITS
Supply Voltage Range	V_{CC}	Inferred from the PSRR test	$T_A = +25^\circ C$	1.8		5.5
Supply Current	I_{CC}	$V_{CC} = 1.6V$	$T_A = +25^\circ C$		0.75	μA
		$V_{CC} = 5V$	$T_A = +25^\circ C$		0.80	
			$T_A = T_{MIN} \text{ to } T_{MAX}$		1.60	
IN+ Voltage Range	V_{IN+}	Inferred from the output swing test	$V_{EE} - 0.2$		$V_{CC} + 0.2$	V
Input Offset Voltage	V_{OS}	(Note 2)	$T_A = +25^\circ C$	1	5	mV
			$T_A = T_{MIN} \text{ to } T_{MAX}$		10	
Input-Referred Hysteresis	V_{HB}	(Note 3)		4		mV
Input Bias Current	I_B	$T_A = +25^\circ C$		0.15	1	nA
		$T_A = T_{MIN} \text{ to } T_{MAX}$			2	
Power-Supply Rejection Ratio	PSRR	$V_{CC} = 1.8V$ to $5.5V$		0.1	1	mV/V
Output-Voltage Swing High	$V_{CC} - V_{OH}$	$V_{CC} = 5V$, $I_{SOURCE} = 8mA$	$T_A = +25^\circ C$	190	400	mV
			$T_A = T_{MIN} \text{ to } T_{MAX}$		500	
		$V_{CC} = 1.8V$, $I_{SOURCE} = 1mA$	$T_A = +25^\circ C$	55	200	
			$T_A = T_{MIN} \text{ to } T_{MAX}$		300	
Output-Voltage Swing Low	V_{OL}	$V_{CC} = 5V$, $I_{SINK} = 8mA$	$T_A = +25^\circ C$	190	400	mV
			$T_A = T_{MIN} \text{ to } T_{MAX}$		500	
		$V_{CC} = 1.8V$, $I_{SINK} = 1mA$	$T_A = +25^\circ C$	55	200	
			$T_A = T_{MIN} \text{ to } T_{MAX}$		300	
Output Short-Circuit Current	I_{SC}	Sourcing, $V_O = V_{EE}$	$V_{CC} = 5V$	95		mA
			$V_{CC} = 1.8V$	8		
		Sinking, $V_O = V_{CC}$	$V_{CC} = 5V$	98		
			$V_{CC} = 1.8V$	10		
High-to-Low Propagation Delay (Note 4)	t_{PD^-}	$V_{CC} = 1.8V$		17		μs
		$V_{CC} = 5V$		22		
Low-to-High Propagation Delay (Note 4)	t_{PD^+}		$V_{CC} = 1.8V$	30		μs
			$V_{CC} = 5V$	95		
Rise Time	t_{RISE}	$C_L = 15pF$		6		μs
Fall Time	t_{FALL}	$C_L = 15pF$		4		μs
Power-Up Time	t_{ON}			1.2		ms
Reference Voltage	V_{REF}	$T_A = +25^\circ C$		1.227	1.245	V
		$T_A = T_{MIN} \text{ to } T_{MAX}$		1.200	1.290	
Reference Voltage Temperature Coefficient	TCV_{REF}				95	ppm/ $^\circ C$
Reference Output Voltage Noise	e_n	BW = 10Hz to 100kHz			600	μV_{RMS}
		BW = 10Hz to 100kHz, $C_{REF} = 1nF$			215	
Reference Line Regulation	$\Delta V_{REF} / \Delta V_{CC}$	$V_{CC} = 1.8V$ to $5.5V$		0.1		mV/V
Reference Load Regulation	$\Delta V_{REF} / \Delta I_{OUT}$	$\Delta I_{OUT} = 10nA$		± 0.2		mV/nA

Note 1: All specifications are 100% tested at $T_A = +25^\circ C$. Specification limits over temperature ($T_A = T_{MIN} \text{ to } T_{MAX}$) are guaranteed by design, not production tested.

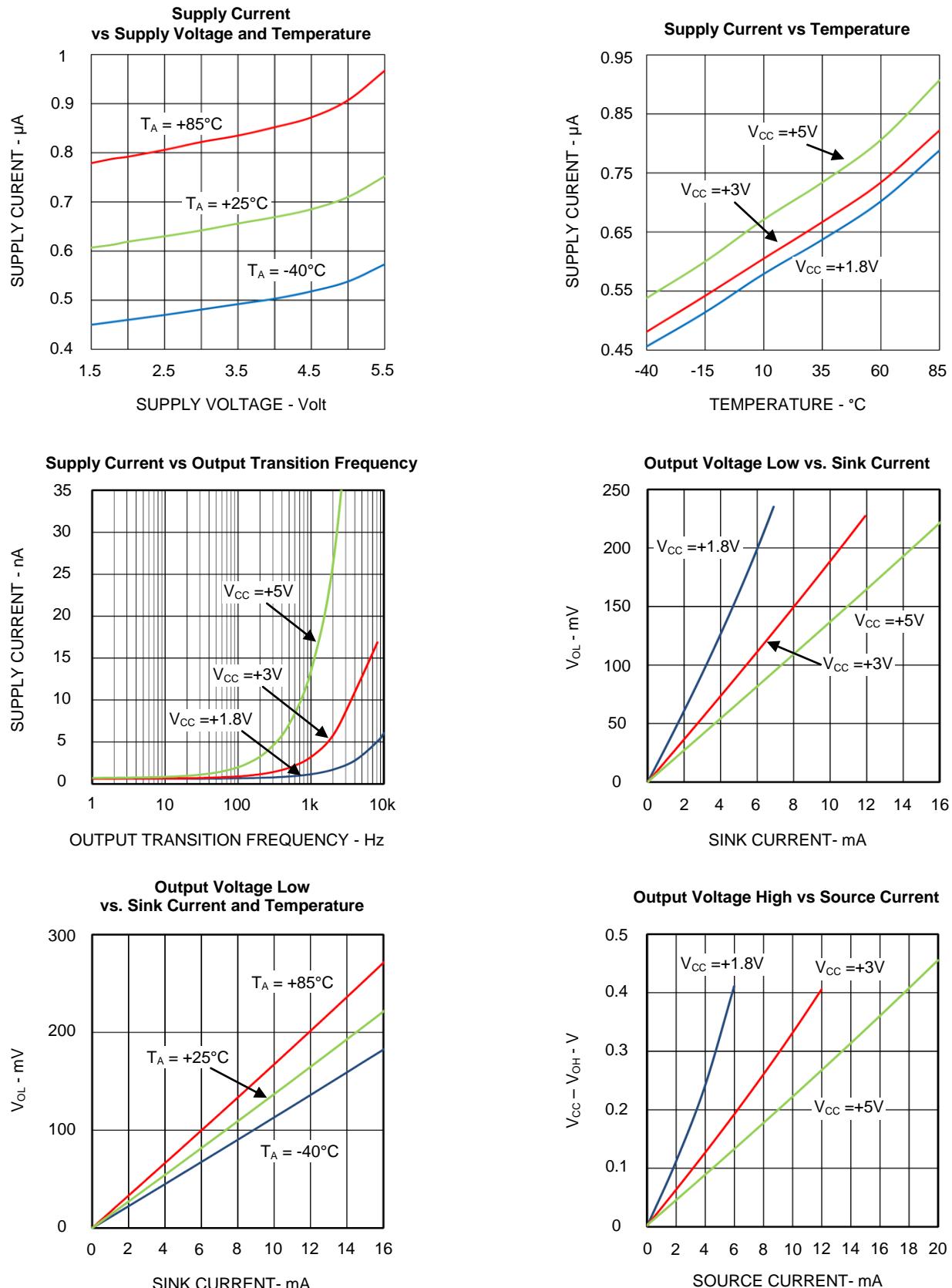
Note 2: V_{OS} is defined as the center of the hysteresis band at the input.

Note 3: The hysteresis-related trip points are defined by the edges of the hysteresis band, measured with respect to the center of the hysteresis band (i.e., V_{OS}) (See Figure 2).

Note 4: Specified with an input overdrive ($V_{OVERDRIVE}$) of 100mV, and load capacitance of $C_L = 15pF$. $V_{OVERDRIVE}$ is defined above and beyond the offset voltage and hysteresis of the comparator input. For the TSM917, reference voltage error should also be added.

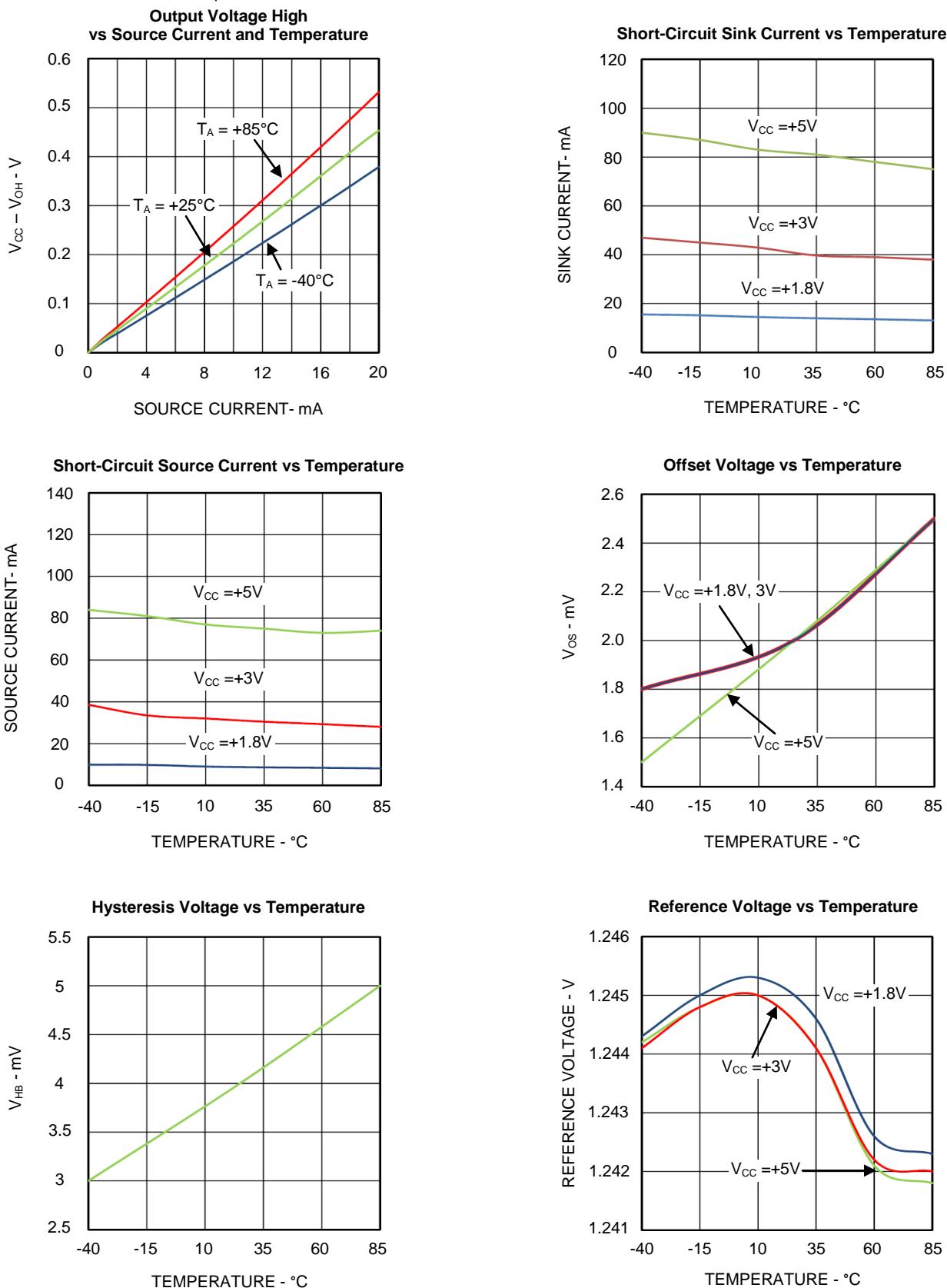
TYPICAL PERFORMANCE CHARACTERISTICS

$V_{CC} = +5V$; $V_{EE} = 0V$; $C_L = 15pF$; $V_{OVERDRIVE} = 100mV$; $T_A = +25^{\circ}C$, unless otherwise noted.



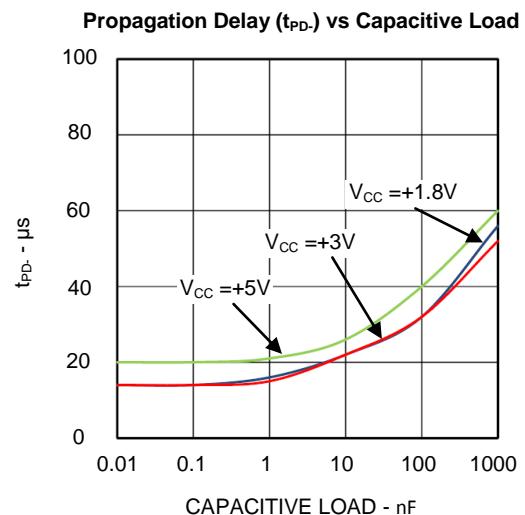
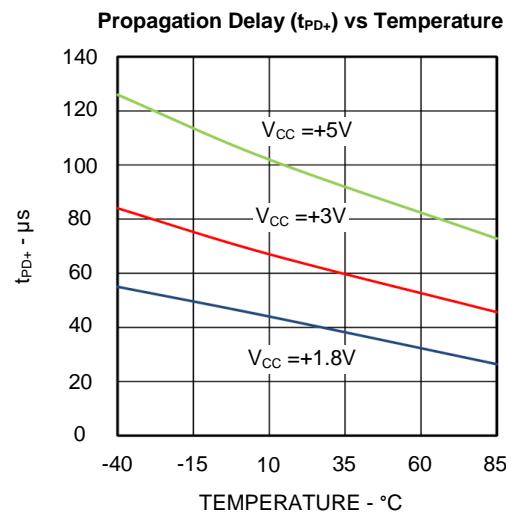
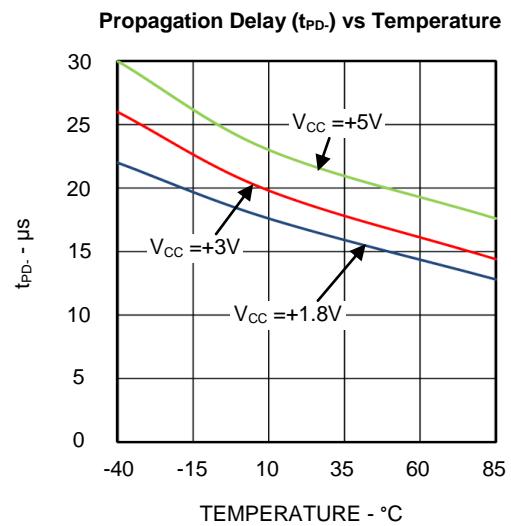
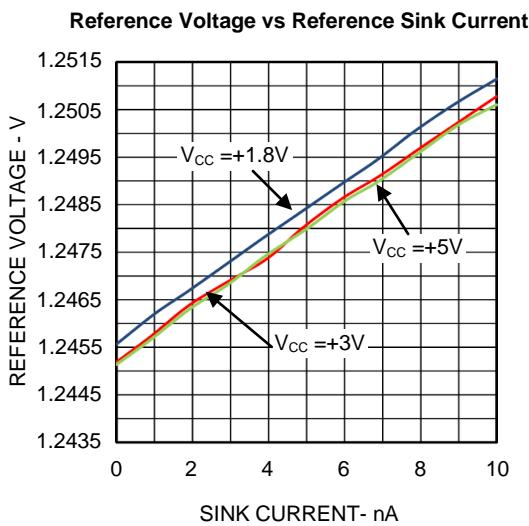
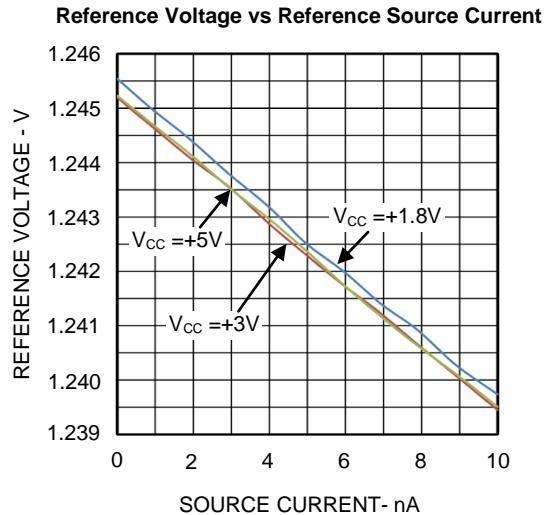
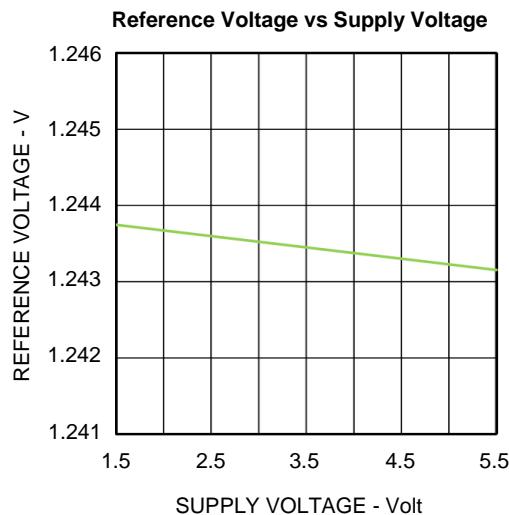
TYPICAL PERFORMANCE CHARACTERISTICS

$V_{CC} = +5V$; $V_{EE} = 0V$; $C_L = 15pF$; $V_{OVERDRIVE} = 100mV$; $T_A = +25^\circ C$, unless otherwise noted.



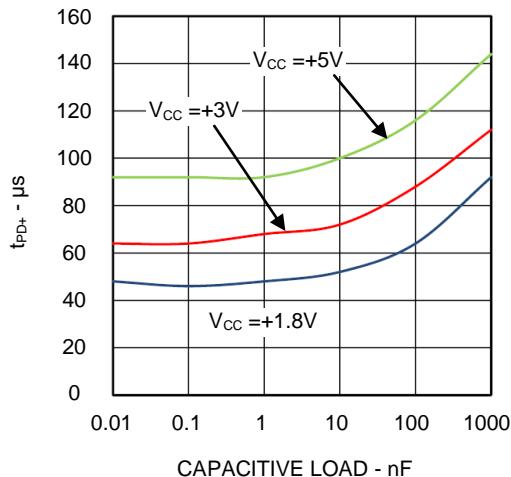
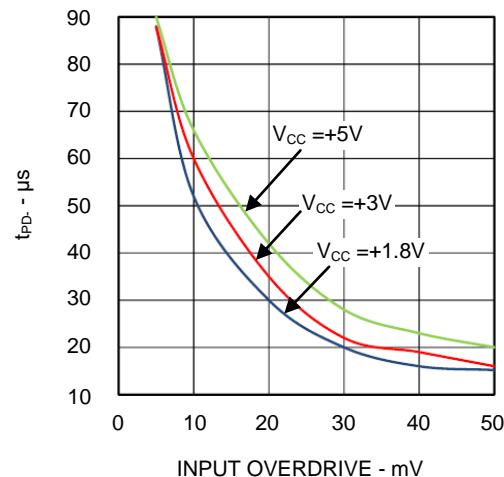
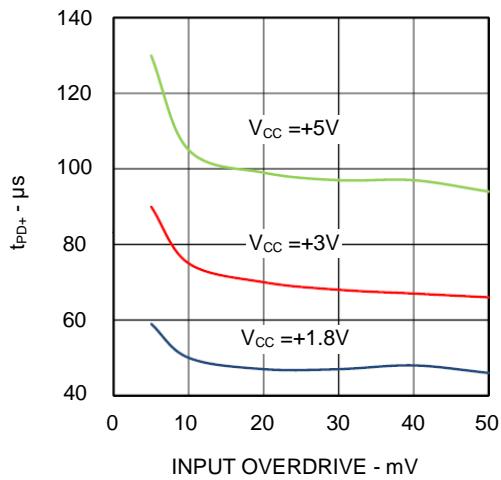
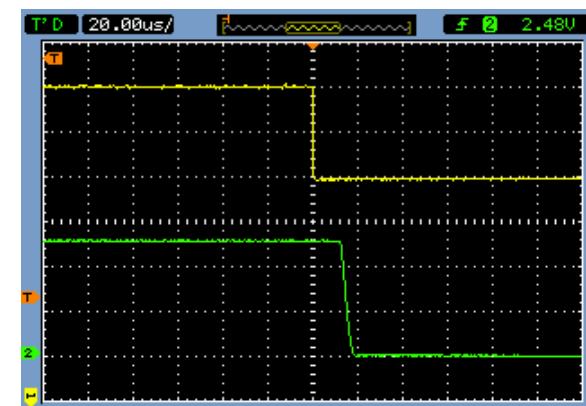
TYPICAL PERFORMANCE CHARACTERISTICS

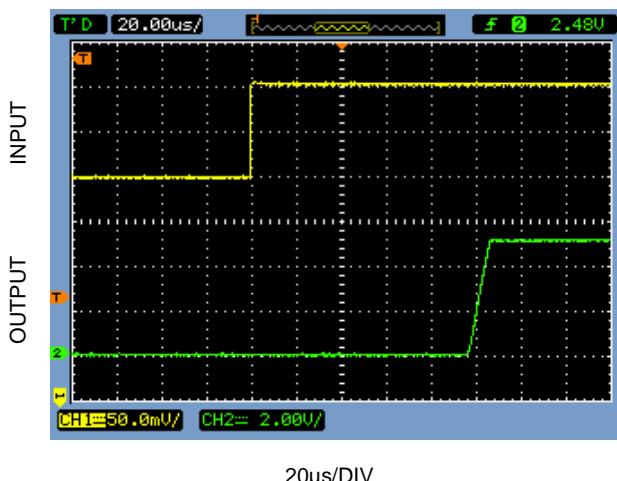
$V_{CC} = +5V$; $V_{EE} = 0V$; $C_L = 15pF$; $V_{OVERDRIVE} = 100mV$; $T_A = +25^\circ C$, unless otherwise noted.

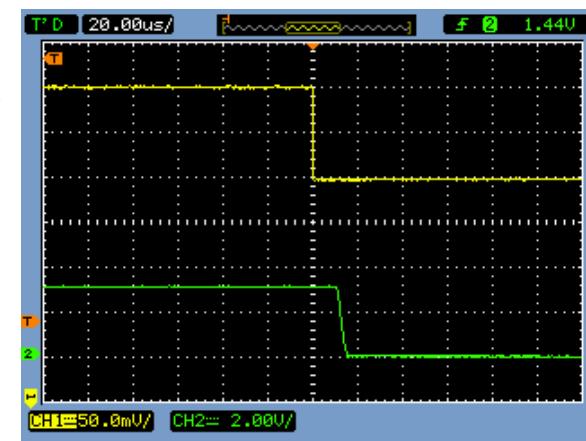


TYPICAL PERFORMANCE CHARACTERISTICS

 V_{CC} = +5V; V_{EE} = 0V; C_L = 15pF; V_{OVERDRIVE} = 100mV; T_A = +25°C, unless otherwise noted.

Propagation Delay (t_{PD+}) vs Capacitive Load

Propagation Delay (t_{PD-}) vs Input Overdrive

Propagation Delay (t_{PD+}) vs Input Overdrive

Propagation Delay (t_{PD-}) at V_{CC} = +5V

 20 μ s/DIV

Propagation Delay (t_{PD+}) at V_{CC} = +5V

 20 μ s/DIV

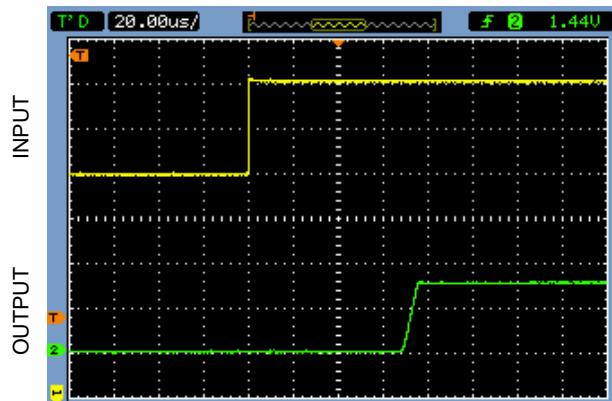
Propagation Delay (t_{PD-}) at V_{CC} = +3V

 20 μ s/DIV

TSM917

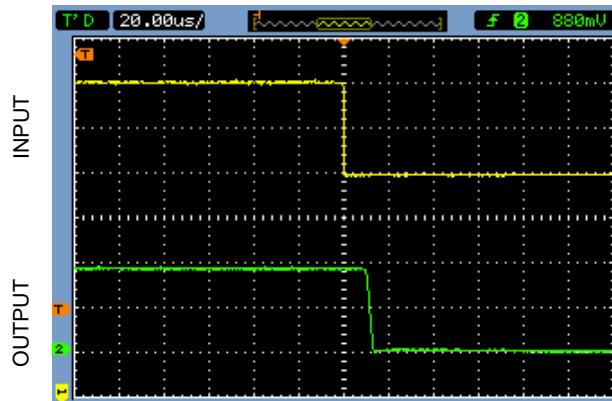
TYPICAL PERFORMANCE CHARACTERISTICS

$V_{CC} = +5V$; $V_{EE} = 0V$; $C_L = 15pF$; $V_{OVERDRIVE} = 100mV$; $T_A = +25^\circ C$, unless otherwise noted.

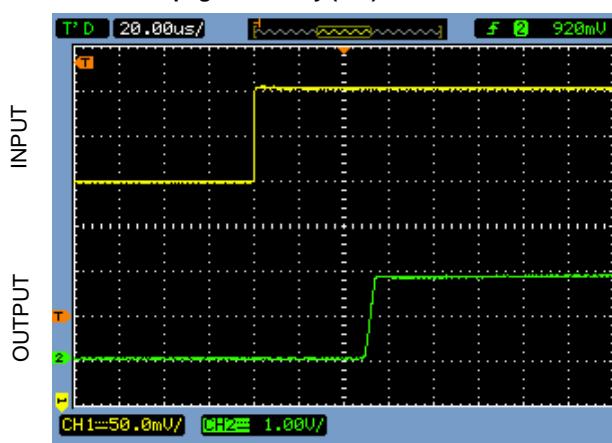
Propagation Delay (t_{PD+}) at $V_{CC} = +3V$



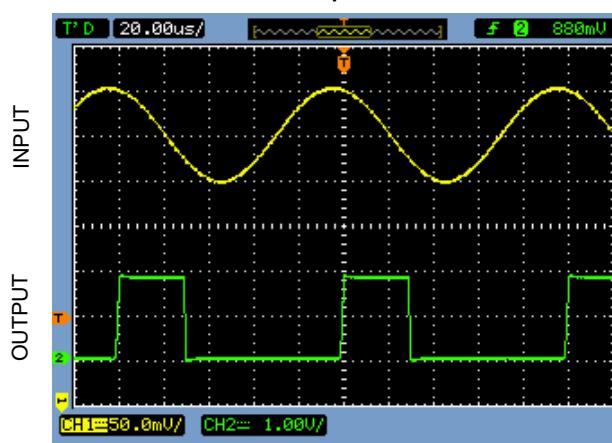
Propagation Delay (t_{PD-}) at $V_{CC} = +1.8V$



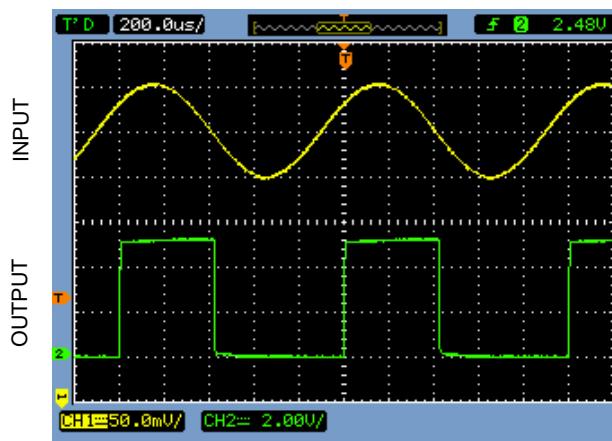
Propagation Delay (t_{PD+}) at $V_{CC} = +1.8V$



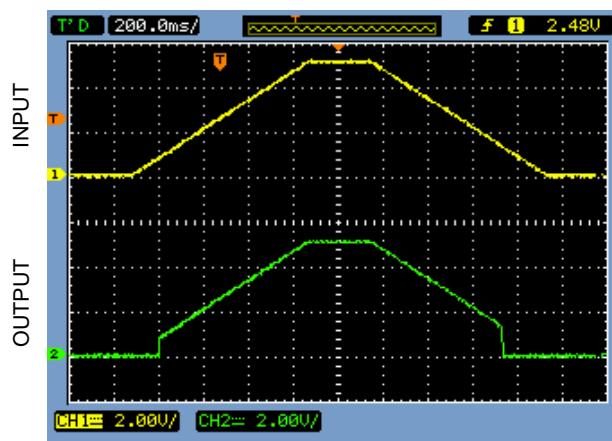
10kHz Transient Response at $V_{CC} = +1.8V$



1kHz Transient Response at $V_{CC} = +5V$



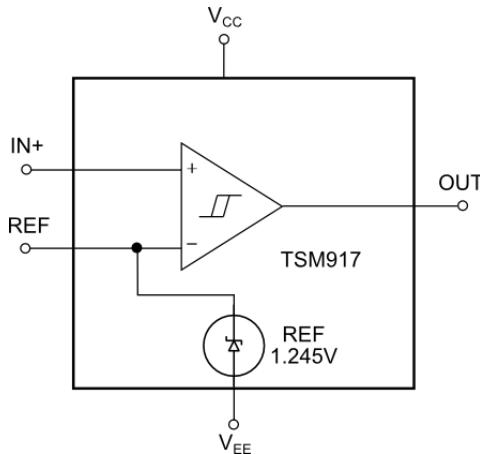
Power-Up/Power-Down Transient Response



PIN FUNCTIONS

TSM917		NAME	FUNCTION
5-pin SOT23	8-pin SOIC		
1	6	OUT	Comparator Output
2	4	VEE	Negative Supply Voltage
3	3	IN+	Comparator Noninverting Input
4	2	REF	1.245V Reference Output and Comparator Inverting Input
5	7	VCC	Positive Supply Voltage
—	—	IN-	Comparator Inverting Input
—	1, 5, 8	NC	No Connection. Not internally connected.

BLOCK DIAGRAMS



DESCRIPTION OF OPERATION

Guaranteed to operate from +1.8V supplies, the TSM917 analog comparator only draws 750nA supply current, features a robust input stage that can tolerate input voltages 200mV beyond the power supply rails, and includes an on-board +1.245V $\pm 1.5\%$ voltage reference. To insure clean output switching behavior, the TSM917 features 4mV internal hysteresis. The TSM917's push-pull output drivers were designed to minimize supply-current surges while driving $\pm 8\text{mA}$ loads with rail-to-rail output swings.

Input Stage Circuitry

The robust design of the analog comparator's input stage can accommodate any differential input voltage from $V_{EE} - 0.2\text{V}$ to $V_{CC} + 0.2\text{V}$. Input bias currents are typically $\pm 0.15\text{nA}$ so long as the applied input voltage remains between the supply rails. ESD protection diodes - connected internally to the supply rails - protect comparator inputs against overvoltage conditions. However, if the applied input voltage exceeds either or both supply rails, an increase in input current can occur when these ESD protection diodes start to conduct.

Output Stage Circuitry

Many conventional analog comparators can draw orders of magnitude higher supply current when switching. Because of this behavior, additional power supply bypass capacitance may be required to provide additional charge storage during switching. The design of the TSM917's rail-to-rail output stage implements a technique that virtually eliminates supply-current surges when output transitions occur. As shown on Page 4 of the Typical Operating Characteristics, the supply-current change as a function of output transition frequency exhibited by this analog comparator family is very small. Material benefits of this attribute to battery-power applications are the increase in operating time and in reducing the size of power-supply filter capacitors.

TSM917's Internal +1.245V V_{REF}

The TSM917's internal +1.245V voltage reference exhibits a typical temperature coefficient of 95ppm/ $^{\circ}\text{C}$ over the full -40°C to $+85^{\circ}\text{C}$ temperature range. An equivalent circuit for the reference section is illustrated in Figure 1. Since the output impedance of the voltage reference is typically $200\text{k}\Omega$, its output

can be bypassed with a low-leakage capacitor and is stable for any capacitive load. An external buffer –

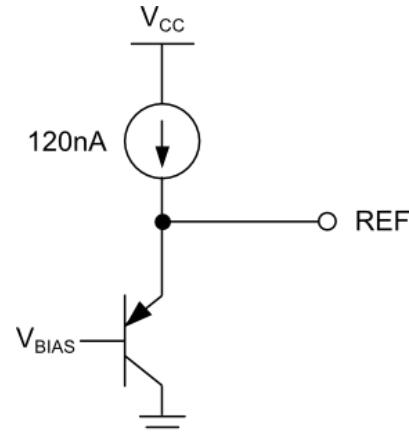


Figure 1: TSM917's Internal V_{REF} Output Equivalent Circuit

such as the TS1001 – can be used to buffer the voltage reference output for higher output current drive or to reduce reference output impedance.

APPLICATIONS INFORMATION

Low-Voltage, Low-Power Operation

Because it was designed specifically for any low-power, battery-operated application, the TSM917 analog comparator is an excellent choice. Under nominal conditions, approximate operating times for this analog comparator is illustrated in Table 1 for a number of battery types and their corresponding charge capacities.

Internal Hysteresis

As a result of circuit noise or unintended parasitic feedback, many analog comparators often break into

oscillation within their linear region of operation especially when the applied differential input voltage approaches 0V (zero volt). Externally-introduced hysteresis is a well-established technique to stabilize analog comparator behavior and requires external components. As shown in Figure 2, adding comparator hysteresis creates two trip points: V_{THR} (for the rising input voltage) and V_{THF} (for the falling input voltage). The hysteresis band (V_{HB}) is defined as the voltage difference between the two trip points. When a comparator's input voltages are equal, hysteresis effectively forces one comparator input to

Table 1: Battery Applications using the TSM917

BATTERY TYPE	RECHARGEABLE	V_{FRESH} (V)	$V_{END-OF-LIFE}$ (V)	CAPACITY, AA SIZE (mA-h)	TSM917 OPERATING TIME (hrs)
Alkaline (2 Cells)	No	3.0	1.8	2000	2.5×10^6
Nickel-Cadmium (2 Cells)	Yes	2.4	1.8	750	937,500
Lithium-Ion (1 Cell)	Yes	3.5	2.7	1000	1.25×10^6
Nickel-Metal-Hydride (2 Cells)	Yes	2.4	1.8	1000	1.25×10^6

move quickly past the other input, moving the input out of the region where oscillation occurs. Figure 2 illustrates the case in which an IN- input is a fixed voltage and an IN+ is varied. If the input signals were reversed, the figure would be the same with an inverted output. To save cost and external PCB area, an internal 4mV hysteresis circuit was added to the TSM917.

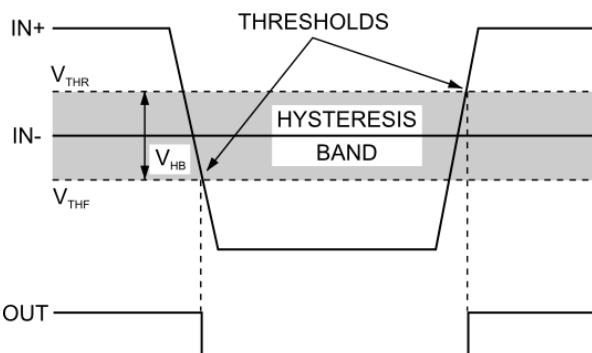


Figure 2: TSM917's Threshold Hysteresis Band

Adding Hysteresis to the TSM917

The TSM917 exhibits an internal hysteresis band (V_{HB}) of 4mV. Additional hysteresis can be generated with three external resistors using positive feedback as shown in Figure 3. Unfortunately, this method also reduces the hysteresis response time. The design procedure below can be used to calculate resistor values.

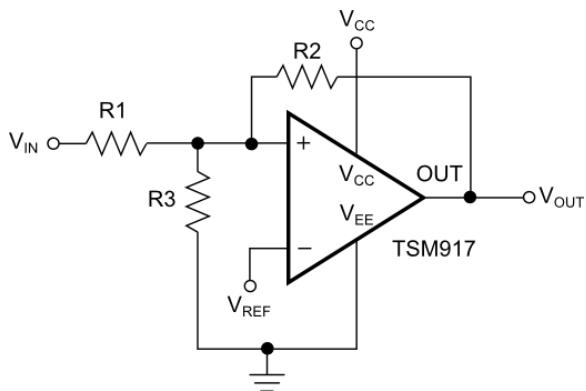


Figure 3: Using Three Resistors Introduces Additional Hysteresis in the TSM917.

- 1) Setting R2. As the leakage current at the IN pin is under 2nA, the current through R2 should be at least 0.2 μ A to minimize offset voltage errors caused by the input leakage current. The current through R2 at the trip

point is $(V_{REF} - V_{OUT})/R2$.

In solving for R2, there are two formulas – one each for the two possible output states:

$$R2 = V_{REF}/I_{R2}$$

or

$$R2 = (V_{CC} - V_{REF})/I_{R2}$$

From the results of the two formulae, the smaller of the two resulting resistor values is chosen. For example, when using the TSM917 ($V_{REF} = 1.245V$) at a $V_{CC} = 3.3V$ and if $I_{R2} = 0.2\mu A$ is chosen, then the formulae above produce two resistor values: 6.23M Ω and 10.24M Ω - the 6.2M Ω standard value for R2 is selected.

- 2) Next, the desired hysteresis band (V_{HYSB}) is set. In this example, V_{HYSB} is set to 100mV.
- 3) Resistor R1 is calculated according to the following equation:

$$R1 = R2 \times (V_{HB}/V_{CC})$$

and substituting the values selected in 1) and 2) above yields:

$$R1 = 6.2M\Omega \times (100mV/3.3V) = 187.88k\Omega$$

The 187k Ω standard value for R1 is selected.

- 4) The trip point for V_{IN} rising (V_{THR}) is chosen such that $V_{THR} > V_{REF} \times (R1 + R2)/R2$ (where V_{THF} is the trip point for V_{IN} falling). This is the threshold voltage at which the comparator switches its output from low to high as V_{IN} rises above the trip point. In this example, V_{THR} is set to 3V.
- 5) With the V_{THR} from Step 4 above, resistor R3 is then computed as follows:

$$R3 = 1/[V_{THR}/(V_{REF} \times R1) - (1/R1) - (1/R2)]$$

$$R3 = 1/[3V/(1.245V \times 187k\Omega) - (1/187k\Omega) - (1/6.2M\Omega)] = 135.56k\Omega$$

In this example, a 137k Ω , 1% standard value resistor is selected for R3.

- 6) The trip voltages and hysteresis band should be verified as follows:

For V_{IN} rising: $V_{THR} = V_{REF} \times R1 \times [(1/R1) + (1 / R2) + (1 / R3)] = 3V$

For V_{IN} falling: $V_{THF} = V_{THR} - (R1 \times V_{CC}/R2) = 2.9V$

and Hysteresis Band = $V_{THR} - V_{THF} = 100mV$

PC Board Layout and Power-Supply Bypassing

While power-supply bypass capacitors are not typically required, it is always good engineering practice to use 0.1uF bypass capacitors close to the device's power supply pins when the power supply impedance is high, the power supply leads are long, or there is excessive noise on the power supply traces. To reduce stray capacitance, it is also good engineering practice to make signal trace lengths as short as possible. Also recommended are a ground plane and surface mount resistors and capacitors.

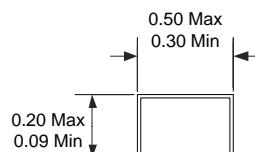
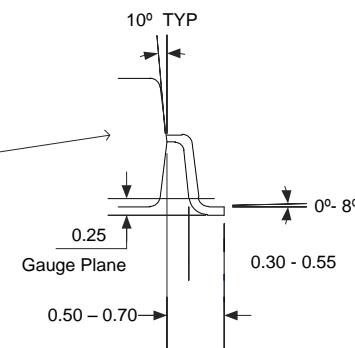
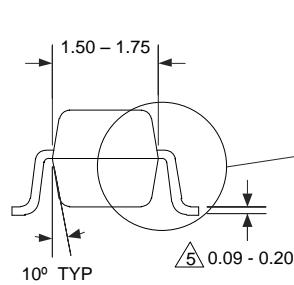
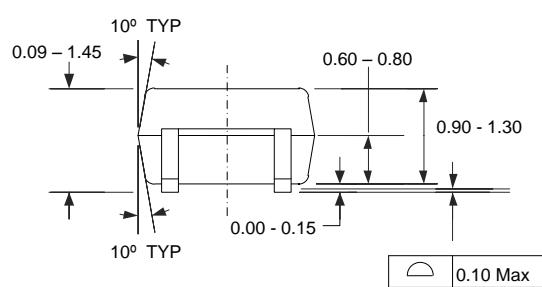
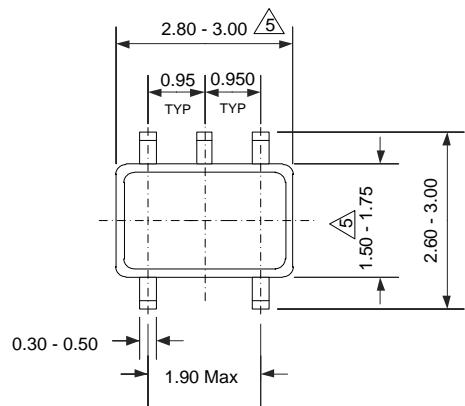
PACKAGE OUTLINE DRAWING

5-Pin SOT23 Package Outline Drawing

(N.B., Drawings are not to scale)

NOTES:

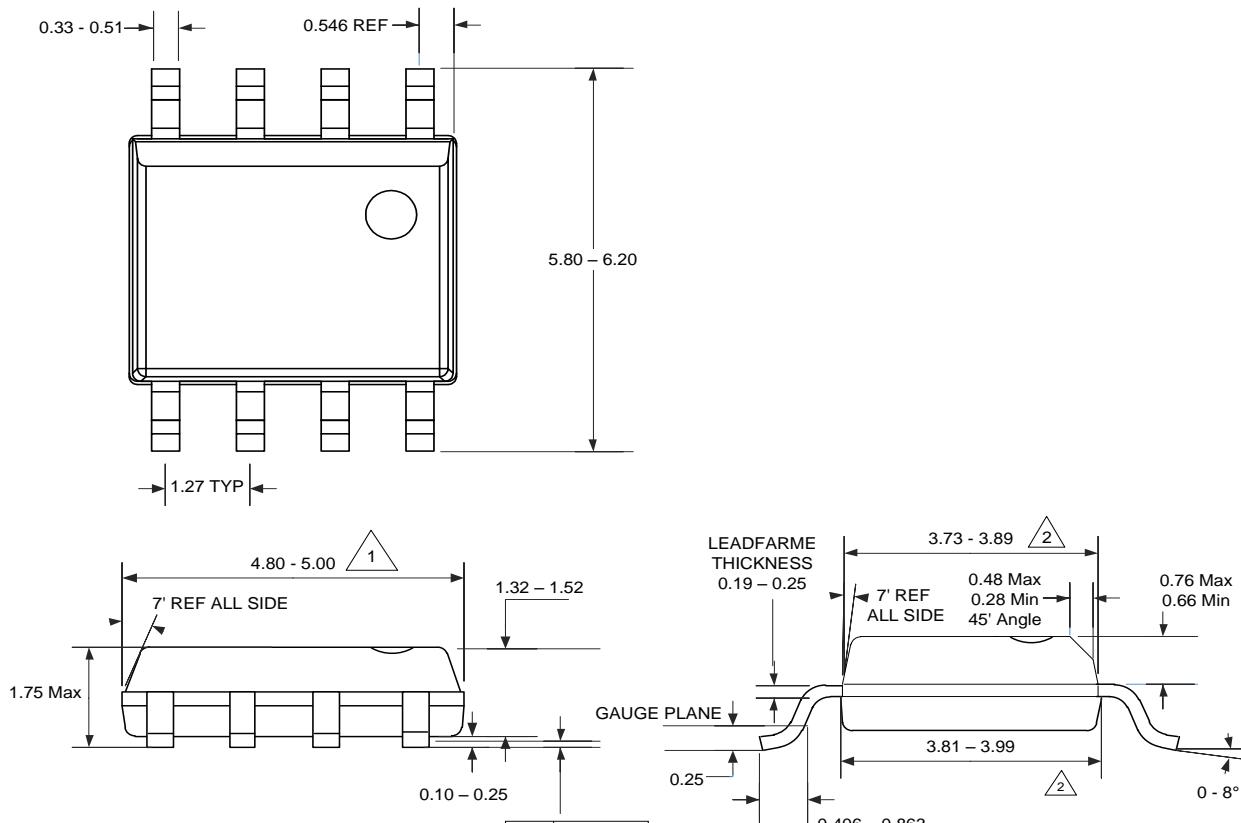
1. Dimensions and tolerances are as per ANSI Y14.5M, 1982.
2. Package surface to be matte finish VDI 11~13.
3. Die is facing up mold and facing down for trim/form, ie, reverse trim/form.
4. The foot length measuring is based on the gauge plane method.
5. Dimensions are exclusive of mold flash and gate burr.
6. Dimensions are exclusive of solder plating.
7. All dimensions are in mm.
8. This part is compliant with EIAJ spec. and JEDEC MO-178 AA
9. Lead span/stand off height/coplanarity are considered as special characteristic.



PACKAGE OUTLINE DRAWING

8-Pin SOIC Package Outline Drawing

(N.B., Drawings are not to scale)



Notes:



1 Does not include mold flash, protrusions or gate burns. Mold flash, protrusions or gate burrs shall not exceed 0.15 mm per side.



2 Does not include inter-lead flash or protrusions. Inter-lead flash or protrusions shall not exceed 0.25 mm per side.

3. Lead span/stand off height/coplanarity are considered as special characteristic (s).
4. Controlling dimensions are in mm.
5. This part is compliant with JEDEC specification MS-012
6. Lead span/stand off height/coplanarity are considered as Special characteristic.

Information furnished by Touchstone Semiconductor is believed to be accurate and reliable. However, Touchstone Semiconductor does not assume any responsibility for its use nor for any infringements of patents or other rights of third parties that may result from its use, and all information provided by Touchstone Semiconductor and its suppliers is provided on an AS IS basis, WITHOUT WARRANTY OF ANY KIND. Touchstone Semiconductor reserves the right to change product specifications and product descriptions at any time without any advance notice. No license is granted by implication or otherwise under any patent or patent rights of Touchstone Semiconductor. Touchstone Semiconductor assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using Touchstone Semiconductor components. To minimize the risk associated with customer products and applications, customers should provide adequate design and operating safeguards. Trademarks and registered trademarks are the property of their